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PATENT
03141-P0418B WWW/TMO

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant	Andrew Tipler
Serial No. 10/621,942	Filing Date: July 17, 2003
Title of Application:	Method For Measuring Effective Temperature Inside A Sealed Container
Confirmation No.	Art Unit:
Examiner	

Commissioner for Patents
Post Office Box 1450
Alexandria, VA 22313-1450

Information Disclosure Statement by Applicant

Dear Sir:

As a means of complying with the duty of disclosure set forth in 37 CFR §1.56, Applicant lists the following references which were cited in the parent case, Serial No. 10/079,712. The examiner is requested to inspect that file if he wishes to see the full texts of the cited art.

U.S. Patent Documents				
Exam. Initials	Class/ Subclass.	Document No.	Date	Name
PSH	62/37	5,431,023	7/11/1995	Howard, et al.
	422/83	5,441,700	8/15/1995	Markelov
	422/83	5,792,423	8/11/1998	Markelov
	436/181	5,932,482	8/3/1999	Markelov

Mailing Certificate: I hereby certify that this correspondence is today being deposited with the U.S. Postal Service as *First Class Mail* in an envelope addressed to: Commissioner of Patents and Trademarks; Post Office Box 1450; Alexandria, VA 22313-1450.

November 17, 2003

Linda A. Ferranti
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U.S. Patent Documents				
Exam. Initials	Class/ Subclass.	Document No.	Date	Name
PSH	436/47	6,146,895	11/14/2000	

Other Documents	
Exam. Initials	Description (Author, Title, Date, Pages, etc)
PSH	James Chickos, et al.; Sublimation enthalphies at 298.15K using gas chromatography and differential scanning calorimetry measurements; 1998; 10 pages

The listed patents pertain in a general way to the subject matter of the application, but are not necessarily considered to be analogous prior art.

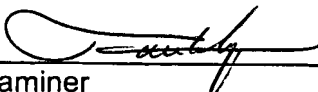
Respectfully submitted,

November 17, 2003



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6/20/07
Date Considered


Examiner